## WHAT IS CLAIMED IS:

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1	1	- A chemical	mechanical	nolighing	method	comprising:
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- determining a vertical position of a top surface of a polishing pad in a chemical
- 3 mechanical polishing system using a pad height sensor;
- 4 positioning a window disposed in an aperture of the polishing pad such that the
- 5 top surface of the window is at about the same vertical position of the top surface of the
- 6 pad based on the determination; and
- 7 polishing a wafer.
- 1 2. The method of claim 1, further comprising:
- determining an endpoint of the polishing; and
- 3 stopping the polishing upon reaching the endpoint.
- 1 3. The method of claim 1, further comprising draining slurry and waste product from
- 2 the aperture.
- 1 4. The method of claim 1, further comprising:
- 2 lowering the window; and
- 3 conditioning the pad after lowering the window.
- 5. The method of claim 1, wherein the window is coated with a slurry-phobic
- 2 substance.

- 1 6. The method of claim 1, wherein determining the height comprises:
- determining a distance between a pad height sensor positioned above a polishing
- 3 pad and the polishing pad; and
- 4 subtracting the determined distance from a known distance between the pad
- 5 height sensor and a surface on which the polishing pad rests.
- 1 7. The method of claim 1, further comprising:
- 2 positioning additional windows disposed in apertures of the polishing pad such
- 3 that the top surface of each window is at about same vertical position of the top surface of
- 4 the pad.
- 1 8. A CMP system, comprising:
- a polishing pad having an aperture;
- a pad height sensor positioned above the polishing pad;
- a window vertically moveable within the aperture; and
- a window raising mechanism capable of adjusting the vertical position of the
- 6 window based on information from the pad height sensor.
- 1 9. The system of claim 8, further comprising an endpoint measurement sensor
- 2 positioned beneath the window.
- 10. The system of claim 8, further comprising a drain disposed in the aperture.

- 1 11. The system of claim 8, further comprising a pad dresser.
- 1 12. The system of claim 8, wherein the window is coated with a slurry-phobic
- 2 substance.
- 1 13. The system of claim 8, further comprising additional windows, each window
- 2 disposed in an additional aperture of the polishing pad, and wherein each window is
- movable between a lowered position and raised position at about the height of the
- 4 polishing pad as determined by the pad height sensor.
- 1 14. The system of claim 8, wherein the window rests on an inflatable toroid coupled
- 2 to a pump.
- 1 15. The system of claim 8, wherein the window rests on a plurality of cylinders, each
- 2 partially disposed in an airtight chamber coupled to a solenoid valve.
- 1 16. A CMP system, comprising:
- 2 means for determining a vertical position of a top surface of a polishing pad in a
- 3 chemical mechanical polishing system;
- 4 means for positioning a window disposed in an aperture of the polishing pad such
- 5 that the top surface of the window is at about the same vertical position of the top surface
- 6 of the pad based on feedback from the means for determining and

- 7 means for polishing a wafer.
- 1 17. A CMP control system, comprising:
- a rate/height data structure holding data indicating the relationship between the
- 3 vertical position of a window disposed within an aperture of a polishing pad and control
- 4 data for a window-raising mechanism;
- a sensor engine capable of receiving distance data from a pad height sensor
- 6 positioned above the polishing pad;
- a pump engine, communicatively coupled to the sensor engine and the data
- 8 structure, capable of sending commands to the window-raising mechanism based on
- 9 control data related to the received distance data, to raise the window to about the height
- of the polishing pad.
- 1 18. The system of claim 17, wherein the window raising mechanism is a pump
- 2 coupled to an inflatable toroid.
- 1 19. The system of claim 17, wherein the window raising mechanism is a solenoid
- 2 valve coupled to a plurality of chambers having cylinders disposed therein.
- 1 20. A computer-readable medium having stored thereon instructions to cause a
- 2 computer to execute a method, the method comprising:
- 3 receiving distance data from a pad height sensor positioned above a polishing pad;
- 4 calculating a height of the polishing pad based on the received distance data; and

- 5 transmitting an instruction to a window-raising mechanism based on the
- 6 calculation that will the raise a window disposed within an aperture of a polishing pad to
- 7 about the calculated height of the polishing pad.
- 1 21. The computer-readable medium of claim 20, wherein the window raising
- 2 mechanism is a pump coupled to an inflatable toroid.
- 1 22. The computer-readable medium of claim 20, wherein the window raising
- 2 mechanism is a solenoid valve coupled to a plurality of chambers having cylinders
- 3 disposed therein.
- 1 23. A chemical mechanical polishing system, comprising:
- a platen; and
- a raised window coupled to the platen and sized to fit within an aperture of a
- 4 polishing pad.
- 1 24. The system of claim 23, further comprising a drain system disposed in the platen,
- the drain system having an orifice positioned near the window.
- 1 25. The system of claim 23, wherein the window is coupled to the platen via a
- window-raising mechanism.